


<b>Search Notes</b>  	<b>Application/Control No.</b>  10735107	<b>Applicant(s)/Patent Under Reexamination</b>  KAO ET AL.
	<b>Examiner</b>  Rutz, Jared I	<b>Art Unit</b>  2187

SEARCHED			
Class	Subclass	Date	Examiner
711	5, 216	11/09/2006	jir
707	6	11/09/2006	jir

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in EAST and PALM	07/20/2006	jir
text search and text limited classification search, see search history	07/20/2006	jir
Fast and Focused search	07/20/2006	jir
Consulted Brian Peugh	07/20/2006	jir
Consulted Kevin Ellis	11/09/2006	jir

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
711	5, 216	11/9/2006	jir
707	6	11/9/2006	jir